



# Information & Control NA TC Chapter Meeting Summary and Minutes

Winter Meetings  
Wednesday, February 26, 2025  
9:00-12:00, 1:00-4:00 PM Pacific Time  
SEMI HQ, Milpitas

## TC Chapter Announcements

*Next TC Chapter Meeting*

Wednesday, June 4, 2025

9:00-12:00, 1:00-4:00 PM Pacific Time

SEMI HQ, Milpitas

## Table 1 Meeting Attendees

*Italics indicate virtual participants*

**Co-Chairs:** James Moyne (Applied Materials / University of Michigan), Brian Rubow (Cimetrix), Albert Fuchigami (PEER Group)

**SEMI Staff:** Michelle Sun

<i>Company</i>	<i>Last</i>	<i>First</i>	<i>Company</i>	<i>Last</i>	<i>First</i>
Intertek	<i>Thomas</i>	<i>Nicholas</i>	Intel	<i>Bond</i>	<i>Ryan</i>
PDF Solutions	<i>Weber</i>	<i>Alan</i>	Self	<i>Howard</i>	<i>Richard</i>
Schneider Electric	<i>March</i>	<i>Stephen</i>	SEMI	<i>Sun</i>	<i>Michelle</i>
Intel	<i>Maloney</i>	<i>Chris</i>	Hitachi	<i>Toyoshima</i>	<i>Yuko</i>
Arlington Laboratory	<i>Judd</i>	<i>Daniel</i>	AMAT/University of Michigan	<i>Moyne</i>	<i>James</i>
The PEER Group	Albert	Fuchigami			

## Table 2 Leadership Changes

<i>WG/TF/SC/TC Name</i>	<i>Previous Leader</i>	<i>New Leader</i>
EDP Task Force	Shuba Viswanath (Intel) [ <i>stepped down</i> ]	

## Table 3 TC Chapter Structure Changes

<i>Previous WG/TF/SC Name</i>	<i>New WG/TF/SC Name or Status Change</i>
None	

## Table 4 Ballot Results

<i>Document #</i>	<i>Document Title</i>	<i>Committee Action</i>
7240B	Revision to SEMI E157-0324, Specification for Module Process Tracking, with title change to: Specification for Module and Substrate Process Tracking	<b>Passed</b> , Ratification Ballot to be issued



**Table 4 Ballot Results**

<i>Document #</i>	<i>Document Title</i>	<i>Committee Action</i>
7311	Line Item Revision to SEMI E191-1024 - Specification for Computing Device Cybersecurity Status Reporting and SEMI E191.1-1024 - Specification for SECS-II Protocol for Computing Device Cybersecurity Status Reporting	
LI-1	Add additional requirements and clarifications to operating system details to be reported	<b>Failed</b>
LI-2	Address issues raised by TF members	<b>Failed</b>
7312	Line Item Revision to SEMI E5-0224 - Specification for SEMI Equipment Communications Standard 2 Message Content (SECS-II), and SEMI E30-1024 - Specification for the Generic Model for Communications and Control of Manufacturing Equipment (GEM)	
LI-1	Add Well-Known Names to SEMI E5 items and update Well-Known Names in SEMI E30 to match	<b>Passed</b>
LI-2	Address issues raised by Task Force Members	<b>Passed</b>
7316	Revision to SEMI E90-1224 – Specification for Substrate Tracking and SEMI E90.1-1224- Specification for SECS-II Protocol Substrate Tracking	<b>Passed</b>
7321	Line Item Revision to SEMI E120-0922 (Reapproved 1224) Specification for the Common Equipment Model (CEM), SEMI E120.2-1224 Specification for Protocol Buffers for Common Equipment Model (CEM), SEMI E125-1224 Specification for Equipment Self Description (EqSD), SEMI E125.2-1224 Specification for Protocol Buffers for Equipment Self Description (EqSD), SEMI E132-0624 Specification for Equipment Client Authentication and Authorization, SEMI E132.2-1224 Specification for Protocol Buffers for Equipment Client Authentication And Authorization (ECA), SEMI E134-1224 Specification for Data Collection Management, SEMI E134.2-1224 Specification for Protocol Buffers of Data Collection Management, and SEMI E179-1224 Specification for Protocol Buffers Common Components	
LI-1	Provide way to handle data collection errors in cached data reports	<b>Passed</b>
LI-2	Update issues raised by TF members	<b>Failed</b>

#1 **Passed** ballots and line items will be submitted to the ISC Audit & Review Subcommittee for procedural review.

#2 **Failed** ballots and line items were returned to the originating task forces for re-work and re-balloting or abandoning.



**Table 5 Ratification Ballot Results**

<i>Document #</i>	<i>Document Title</i>	<i>ISC A&amp;R Action</i>	<i>A&amp;R Forms</i>
None			

Note 1: **Passed** Ratification ballots will be submitted to SEMI publication for final processing.

Note 2: **Failed** Ratification ballots were returned to the originating task forces for re-work and re-balloting or abandoning.

**Table 6 Activities Approved by the GCS between meetings of the TC Chapter**

<i>#</i>	<i>Type</i>	<i>SC/TF/WG</i>	<i>Details</i>
7321	Ballot Authorization	DDA	Line Item Revision to SEMI E120-0922 (Reapproved 1224) Specification for the Common Equipment Model (CEM), SEMI E120.2-1224 Specification for Protocol Buffers for Common Equipment Model (CEM), SEMI E125-1224 Specification for Equipment Self Description (EqSD), SEMI E125.2-1224 Specification for Protocol Buffers for Equipment Self Description (EqSD), SEMI E132-0624 Specification for Equipment Client Authentication and Authorization, SEMI E132.2-1224 Specification for Protocol Buffers for Equipment Client Authentication And Authorization (ECA), SEMI E134-1224 Specification for Data Collection Management, SEMI E134.2-1224 Specification for Protocol Buffers of Data Collection Management, and SEMI E179-1224 Specification for Protocol Buffers Common Components

**Table 7 Authorized Activities**

Listing of all revised or new SNARF(s) approved by the Originating TC Chapter.

<i>#</i>	<i>Type</i>	<i>SC/TF/WG</i>	<i>Details</i>
7344	SNARF Approval	GEM300	Line Item Revision to SEMI E192-0125 - Guide for Equipment Adoption Criteria for GEM and GEM-related Standards
7345	SNARF Approval	GEM300	Line Item Revision to SEMI E90-1224, Specification for Substrate Tracking and SEMI E90.1-1224, Specification for SECS-II Protocol Substrate Tracking
7355	SNARF Approval	Sensor Bus TF	Reapproval of SEMI E54.22 (Reapproved 0420) - Specification for Sensor/Actuator Network Specific Device Model for Vacuum Pressure Gauges

#1 SNARFs and TFOFs are available for review on the SEMI Web site at:

<http://downloads.semi.org/web/wstdsbal.nsf/TFOFSNARE>

**Table 8 Authorized Ballots**

<i>#</i>	<i>When</i>	<i>TF</i>	<i>Details</i>
6743C	Cycle 3, 4, 5-2025	GUI	Revision to SEMI E95-1101, Specification for Human Interface for Semiconductor Manufacturing Equipment
6926	Cycle 3, 4, 5-2025	CDS	New Standard: Specification for Equipment Operator Access Management and Monitoring
7178	Cycle 3, 4, 5-2025	DDA	Revision to SEMI E164-0414 (Reapproved 0721), Specification for EDA Common Metadata

**Table 8 Authorized Ballots**

#	When	TF	Details
7179	Cycle 3, 4, 5-2025	DDA	Revision to Add a New Subordinate Standard: Specification for EDA Common Metadata for Generic Model for Communication and Control of Manufacturing Equipment (GEM) to SEMI E164-0414 (Reapproved 0721), Specification for EDA Common Metadata
7180	Cycle 3, 4, 5-2025	DDA	Revision to Add a New Subordinate Standard: Specification for EDA Common Metadata for Processing Management to SEMI E164-0414 (Reapproved 0721), Specification for EDA Common Metadata
7311A	Cycle 3, 4, 5-2025	CDS	Line Item Revision to SEMI E191-1024 - Specification for Computing Device Cybersecurity Status Reporting and SEMI E191.1-1024 - Specification for SECS-II Protocol for Computing Device Cybersecurity Status Reporting
7270	Cycle 3, 4, 5-2025	GEM 300	Line Item Revision to SEMI E151-1211 (Reapproved 0517), Guide for Understanding Data Quality
7321A	Cycle 3, 4, 5-2025	DDA	Line Item Revision to SEMI E120-0922 (Reapproved 1224) Specification for the Common Equipment Model (CEM), SEMI E120.2-1224 Specification for Protocol Buffers for Common Equipment Model (CEM), SEMI E125-1224, Specification for Equipment Self Description (EqSD), SEMI E125.2-1224, Specification for Protocol Buffers for Equipment Self Description (EqSD), SEMI E132-0624, Specification for Equipment Client Authentication and Authorization, SEMI E132.2-1224, Specification for Protocol Buffers for Equipment Client Authentication And Authorization (ECA), SEMI E134-1224, Specification for Data Collection Management, SEMI E134.2-1224, Specification for Protocol Buffers of Data Collection Management, and SEMI E179-1224, Specification for Protocol Buffers Common Components
7187	Cycle 3, 4, 5-2025	ESEC	Revision to SEMI E167-1213 - Specification for Equipment Energy Saving Mode Communications (EESM) and SEMI E167.1-1213 - Specification for SECS-II Protocol for Equipment Energy Saving Mode Communications
7344	Cycle 3, 4, 5-2025	GEM300	Line Item Revision to SEMI E192-0125 - Guide for Equipment Adoption Criteria for GEM and GEM-related Standards
7345	Cycle 3, 4, 5-2025	GEM300	Line Item Revision to SEMI E90-1224, Specification for Substrate Tracking and SEMI E90.1-1224, Specification for SECS-II Protocol Substrate Tracking
7346	Cycle 3, 4, 5-2025	Sensor Bus TF	Line Item Revision to SEMI E54.23-0520, Specification for Sensor/Actuator Network Communications for CC-LINK® IE
7347	Cycle 3, 4, 5-2025	Sensor Bus	Reapproval of SEMI E54.18-0914 (Reapproved 0420) - Specification for Sensor/Actuator Network Specific Device Model for Vacuum Pump Device
7348	Cycle 3, 4, 5-2025	Sensor Bus	Reapproval of SEMI E54.23-0520 - Specification for Sensor/Actuator Network Communications for CC-LINK® IE

**Table 9 SNARF(s) Granted a One-Year Extension**

#	TF	Title	Expiration Date
6923	ESEC	Line Item Revisions to SEMI E167-1213: Specification for Equipment Energy Saving Mode Communications (EESM), SEMI E167.1-1213: Specification for SECS-II Protocol for Equipment Energy Saving Mode Communications, and SEMI E175-1116: Specification for Subsystem Energy Saving Mode Communication (SESMC)	2/26/2026
6926	CDS	New Standard: Specification for Equipment Operator Access Management and Monitoring	2/26/2026

**Table 10 SNARF(s) Cancelled**

#	TF	Title
6992	GEM300	Line Item Revision to SEMI E157-0611 (Reapproved 0616), Specification for Module Process Tracking

**Table 11 Standard(s) to receive Inactive Status**

Standard Designation	Title
None	

**Table 12 New Action Items**

Item #	Assigned to	Details
None		

**Table 13 Previous Meeting Action Items**

Item #	Assigned to	Details
None		

## 1 Welcome, Reminders, and Introductions

Brian Rubow (Cimetrix) called the meeting to order at 9:05. The meeting reminders on antitrust issues, intellectual property issues and holding meetings with international attendance were reviewed. Attendees introduced themselves.

**Attachment:** Required Meeting Elements March 2024

## 2 Review of Previous Meeting Minutes

The TC Chapter reviewed the minutes of the previous meeting.

**Motion:** Approve the minutes as written

**By / 2<sup>nd</sup>:** By: Takayuki Nishimura / SCREEN Semiconductor Solutions Co., Ltd.  
Second: Brian Rubow / Cimetrix Incorporated

**Discussion:** None

**Vote:** 11-Y 0-N

**Attachment:** IC-Minutes-Feb-2025

## 3 Liaison Reports

### 3.1 I&C Taiwan TC Chapter

Michelle Sun (SEMI) reported for the Information & Control Taiwan TC Chapter. Of note:

- Last meeting
  - o November 29, 2024
- Next meeting
  - o TBD
- Organization Chart
  - o Equipment Information Integration TF, GEM300 TF, Backend Factory Integration TF disbanded



- Authorized Activities
  - o Major Revision of E187 - Specification for Cybersecurity of Fab Equipment

**Attachment:** IC Taiwan Liaison Report\_20241129\_V1

### 3.2 I&C Japan TC Chapter

Takayuki Nishimura (SCREEN) reported for the I&C Japan TC Chapter. Of note:

- Last meeting
  - o Friday December 13th, 2024, 13:30-16:30 [JST]
  - o International Conference Hall, SEMICON Japan 2024 + OVTCCM [Hybrid]
- Next meeting
  - o Friday April 18th, 2025, 13:30-16:30 [JST]
  - o SEMI Japan Office + OVTCCM [Hybrid]
- Ballot Results
  - o 7005, Line Item Revision to SEMI E91-1217: SPECIFICATION FOR PROBER SPECIFIC EQUIPMENT MODEL (PSEM) [JST]
  - o R7173, Line-Item Revision to SEMI E30-0224, Specification for the Generic Model for Communications and Control of Manufacturing Equipment (GEM) [JST]
- Authorized Ballots
  - o 7334, Line Item Revision to SEMI E174-0819 SPECIFICATION FOR WAFER JOB MANAGEMENT (WJM)
  - o 7330, Line Item Revision to SEMI E178-0120 GUIDE FOR EDA FREEZE VERSION

**Attachment:** JA\_I&C\_Liaison\_2025\_Feb\_Ver2

### 3.3 SEMI Staff Report

Michelle Sun (SEMI) gave the SEMI Staff Report. Of note:

2025 Calendar of Events

Event Name	Event Details
<b>SEMICON<sup>®</sup> CHINA</b>	March 26-28, 2025 Shanghai
<b>SEMICON<sup>®</sup> SOUTHEAST ASIA</b>	May 20-22, 2025 Singapore
<b>SEMICON<sup>®</sup> INDIA</b>	Sept 1-3 New Delhi
<b>SEMICON<sup>®</sup> TAIWAN</b>	Sept 10-12 Taipei
<b>SEMICON<sup>®</sup> WEST</b>	Oct 7-9 Phoenix, Arizona
<b>SEMICON<sup>®</sup> EUROPA</b>	Nov 18-21 Munich, Germany
<b>SEMICON<sup>®</sup> JAPAN</b>	Dec 17-19 Tokyo, Japan

SEMICON West 2025-2030

- 2025—October 7-9 | Phoenix Convention Center | Phoenix, AZ
- 2026—October 13-15 | Moscone Center | San Francisco, CA
- 2027—October 12-14 | Phoenix Convention Center | Phoenix, AZ
- 2028—October 10-12 | Moscone Center | San Francisco, CA
- 2029—October 9-11 | Phoenix Convention Center | Phoenix, AZ



- 2030—October 29-31 | Moscone Center | San Francisco, CA

### Upcoming NA Meetings 2025

Event Name	Date/Venue	Ballot Cycles to Consider
NA Standards Meetings	June 2-5, 2025 SEMI HQ, Milpitas, California/USA	<b>Cycle 3-25</b> Ballot Submission Date: Wednesday, March 5, 2025 Voting Period Starts: Wednesday, March 19, 2025 Voting Period Ends: Friday, April 18, 2025 <b>Cycle 4-25</b> Ballot Submission Date: Thursday, March 20, 2025 Voting Period Starts: Wednesday, April 9, 2025 Voting Period Ends: Friday, May 9, 2025
SEMICON West	Oct 7-9, 2025 Phoenix Convention Center Phoenix, Arizona/USA	<b>Cycle 6-25</b> Ballot Submission Date: Thursday, June 19, 2025 Voting Period Starts: Wednesday, July 9, 2025 Voting Period Ends: Friday, August 8, 2025 <b>Cycle 7-25</b> Ballot Submission Date: Thursday, July 24, 2025 Voting Period Starts: Wednesday, August 13, 2025 Voting Period Ends: Friday, September 12, 2025

### Critical Dates for SEMI Standards Ballots – 2025

2025	Ballot Submission Deadline	Voting Opens	Voting Closes
<b>Cycle 2</b>	January 23	February 11	March 13
<b>Cycle 3</b>	March 5	March 19	April 18
<b>Cycle 4</b>	March 20	April 9	May 9
<b>Cycle 5</b>	May 8	May 28	June 27
<b>Cycle 6</b>	June 19	July 9	August 8
<b>Cycle 7</b>	July 24	August 13	September 12

### SEMI Standards Publications

- Total SEMI Standards in portfolio: 1,098
  - o Includes 356 Inactive Standards

### Regulations & Procedure Manual Updates

- Regulations (Feb 20, 2024)
  - New definition of “Standards Document”
  - Clarification of confidential presentation materials
    - <https://www.semi.org/sites/semi.org/files/2024-02/Standards%20Regulations%20February%202024.pdf>
- Procedure Manual (Sept 27, 2024)
  - Clarification of § 6.4.5.10 for discharging of a TF



- New ¶ 6.4.5.11 Designation of a TF as Dormant.
  - <https://www.semi.org/sites/semi.org/files/2024-09/Procedure%20Manual%20September%202024.pdf>

**Connect@SEMI Communities for all SEMI Standards Task Forces [1/5]**

- By Feb 2025, all Standards Task Forces shall use Connect@SEMI to host documents that are currently in development.
- Each Standards Task Force will have its own Community Page on Connect@SEMI.
- All Program Members may log in at:
  - <https://connect.semi.org>
  - Enter their username and password (same as program membership log-in)

**SNARF 3-Year Status**

Date	Doc	Description
12/08/2021	6894	Line Item Revision to E33-0217E, Guide for Semiconductor Manufacturing Equipment Electromagnetic Compatibility (EMC) and E176-1017, Guide to Assess and Minimize Electromagnetic Interference (EMI) in a Semiconductor Manufacturing Environment
12/06/2021	6971	Revision to SEMI E163-0212, Guide for the Handling of Reticles and Other Extremely Electrostatic Sensitive (EES) Items Within Specially Designated Areas

**Attachment:** IC-Staff Report Feb 2025 v2

**4 Ballot Review**

NOTE 1: TC Chapter adjudication on ballots reviewed is detailed in the Audits & Review (A&R) Subcommittee Forms for procedural review. The A&R forms are available as attachments to these minutes. The attachment number for each balloted document is provided under each ballot review section below.

4.1 Document #7240B, Revision to SEMI E157-0324, Specification for Module Process Tracking, with title change to: Specification for Module and Substrate Process Tracking

**Motion:** This Document passed TC Chapter review with technical changes and with or without editorial changes and will be forwarded to the ISC A&R SC for procedural review. A Ratification Ballot will be issued to verify the technical changes.

**By / 2<sup>nd</sup>:** By: Takayuki Nishimura / SCREEN Semiconductor Solutions Co., Ltd.  
Second: Tami Tracey / Cimatrix Incorporated

**Discussion:** None

**Vote:** 7-Y 0-N

**Attachment:** AR - 7240B v2

4.2 Document #7312, Line Item Revision to SEMI E5-0224 - Specification for SEMI Equipment Communications Standard 2 Message Content (SECS-II), and SEMI E30-1024 - Specification for the Generic Model for Communications and Control of Manufacturing Equipment (GEM)

**Motion:** Line item(s) [1], [2] passed TC Chapter review as balloted and will be forwarded to the ISC A&R SC for procedural review.

**By / 2<sup>nd</sup>:** By: Albert Fuchigami / PEER Group Inc.  
Second: Brian Rubow / Cimatrix Incorporated

**Discussion:** None

**Vote:** 10-Y 0-N



**Attachment:** AR - 7312

4.3 Document #7311, Line Item Revision to SEMI E191-1024 - Specification for Computing Device Cybersecurity Status Reporting and SEMI E191.1-1024 - Specification for SECS-II Protocol for Computing Device Cybersecurity Status Reporting

**Motion:** This Document failed TC Chapter review and will be returned to the TF for rework

**By / 2<sup>nd</sup>:** By: Albert Fuchigami / PEER Group Inc.  
Second: Richard Howard

**Discussion:** None

**Vote:** 9-Y 0-N

4.4 Document #7316, Revision to SEMI E90-1224 – Specification for Substrate Tracking and SEMI E90.1-1224- Specification for SECS-II Protocol Substrate Tracking

**Motion:** This Document passed TC Chapter review as balloted and will be forwarded to the ISC A&R SC for procedural review

**By / 2<sup>nd</sup>:** By: Brian Rubow / Cimatrix Incorporated  
Second: Stephen March / SE

**Discussion:** None

**Vote:** 10-Y 0-N

**Attachment:** AR - 7316

4.5 Document #7321, Line Item Revision to SEMI E120-0922 (Reapproved 1224) Specification for the Common Equipment Model (CEM), SEMI E120.2-1224 Specification for Protocol Buffers for Common Equipment Model (CEM), SEMI E125-1224 Specification for Equipment Self Description (EqSD), SEMI E125.2-1224 Specification for Protocol Buffers for Equipment Self Description (EqSD), SEMI E132-0624 Specification for Equipment Client Authentication and Authorization, SEMI E132.2-1224 Specification for Protocol Buffers for Equipment Client Authentication And Authorization (ECA), SEMI E134-1224 Specification for Data Collection Management, SEMI E134.2-1224 Specification for Protocol Buffers of Data Collection Management, and SEMI E179-1224 Specification for Protocol Buffers Common Components

**Motion:** Line item(s) [1] passed TC Chapter review as balloted and will be forwarded to the ISC A&R SC for procedural review

Line item(s) [2] failed TC Chapter review and will be returned to the TF for rework

**By / 2<sup>nd</sup>:** By: Brian Rubow / Cimatrix Incorporated  
Second: Stephen March / SE

**Discussion:** None

**Vote:** 11-Y 0-N

**Attachment:** AR - 7321

## 5 Subcommittee and Task Force Reports

### 5.1 ABFI Task Force

Brian Rubow (PDF Solutions) reported for the ABFI Task Force. Of note:

- SEMI E192
  - o SEMI E192 is now published.



- SEMI E192 is a guide for all GEM related standards. Therefore, the standard should be updated when new GEM-related standards are created and when the scope changes for an existing GEM-related standard.
- SEMI E90
  - Currently, E90 only supports single substrate id reader availability
  - In some equipment multiple substrate id readers are required due to following reasons
    - Different substrate types (Wafer, Strip, Tray, Panel, TnR, PCB) require different id readers
    - Different material flow of same substrate type would require multiple substrate id readers
    - Substrate may have frontside and backside id, e.g., two bonded wafers
- SEMI E142
  - Use Cases
    - Inspection may be performed on un-patterned wafers.
    - Defect wafer XY coordinates (microns) should be mapped to E142 PhysicalCoordinates
    - Test cells (tester and prober) use their own wafer origin orientation, etc.
    - Device wafer XY coordinates (col, row) should be mapped to E142 LogicalCoordinates
    - Assembly and final test equipment that support mapping should follow E142 SEMI standard
  - Proposal
    - New SNARF for E142 wafer XY mapping table / algorithm
  - Action
    - Liaison with RITdb TF (next meeting Feb 27<sup>th</sup>) – Albert, John
    - Prepare SNARF for E142 wafer XY mapping table / algorithm – Dave

**Attachment:** ABFI TF Meeting\_022425

## 5.2 CDS Task Force

Other Operating System Details to report

Current/Proposed

- OS Details – Computing Device identifier, OS Manufacturer, OS Name, OS Version, OS Build
- OS Installed Updates – OS Updates installed on the computing device
- OS Installed Components – OS components installed on the computing device

Future:

- Factory Network connection details? IP Address (IPv4, IPv6), DNS, HostName, MAC Address
- USB Accessibility? OS details reporting if USB devices are enabled? (removeable storage, human input device, printers, other?)
- Port Management? Open Ports? Attached services?

**Attachment:** CDS TF Meeting 20250225\_v2

## 5.3 DDA Task Force

EDA Software Vendor Tests



- Test Session #3 held in November 2024. 5 participants (1 equipment supplier, 4 solution providers) Focused on SEMI E134 functionality (defining DCPs and getting NewData messages). Issues being addressed in EDA Standards.
- No additional vendor tests planned – if TF members interested in inter-operability testing, individual sessions can be coordinated)

#### EDA Standards Update

- Addressing issues found in Test Session #3 and reported by TF Members.

#### SEMI E164

- Ongoing concentrated ballot development efforts – reworking E164 into Primary Standard approach, defining only general metadata requirements and defining subordinate standard approach for content standard metadata.
- Planning informational ballot for first subordinate standard (SEMI E40 content) to validate approach and complementary files using JSONC format.

**Attachment:** DDA TF Report - February 2025\_Rev 1.0

#### 5.4 GUI Task Force

Tami Tracey (Cimetrix) reported for the GUI Task Force.

##### TF Meeting Results

- Reviewed 6743C draft revision 3.3
- Items discussed in the meeting
  - User selection (cursor) convention for the document
  - Addition of terms *affordance* and *signifier*
  - Screen Layouts ‘Type 1’ and ‘Type 2’
  - Screen Layouts for SSD – Figure revisions
  - Member suggestion to allow adjacent placement of view-to-view navigation area and navigation panel
  - Proposal to use Informational Ballot process

**Attachment:** GUI TF Report - 2025-02-25

#### 5.5 PCS Task Force

James Moyne (AMAT/University of Michigan) reported for the PCS Task Force.

##### TF Meeting Results

- **Date and Event**
  - # of attendees in person: 7 (including staff)
  - # of attendees remote/online: 5
- **TF Leadership & changes (if any): None**
- **New SNARFs: None**
- **Ballot Adjudication: None**
- **New business**
  - **Ballot 7270: Line Item update to SEMI E151-1211, Guide for understanding data quality**
    - Ballot reviewed and will be updated.
  - **SNARF: NEW STANDARD: Specification for Failure Analysis Reporting**
    - Available for review
    - Standard to be developed in the PCS TF
  - **E133 and Digital Twins**
    - Delay in federal funding for Center for Digital Twins has resulted in the delay on the start of this work.

**Attachment:** PCS-TF-report20250224

### 5.6 Sensor Bus Task Force

Dan Judd (Arlington Laboratory) reported for the Sensor Bus Task Force. Of note:

#### Ballot Plans

5-Year	Standard	SAN:C for	Status
10/2023	E54.19-1018	Mechatrolink	SNARF Nov 8, 2023 <b>Dormant</b>
10/2023	E54.17-1018	A-Link	Editor/Expert not found
10/2024	E54.21-1019	MotionNet	Editor/Expert not found
05/2025	E54.23-0520	CC-Link IE	Editor/Expert identified. Ballot expected Cycle 4 2025.

**Attachment:** SensorBusTF-SEMINA-Feb-2025-v0.1

### 5.7 GEM300 Task Force

Brian Rubow (Cimetrix) reported for the GEM300 Task Force. Of note:

#### Meeting Results (Technical Summary)

- Adjudicated Ballots 7312-1, 7312-2, 7316-1, 7240B-1
  - We had several long discussions while adjudicating ballot 7240B-1 (E157).
- Reviewed E90 SNARF
  - There is a contradiction between the state definitions and the transition table regarding the creation and destruction of batches.
  - There is a lack of substrate tracking available to report during batch creation and destruction.
  - Bob, Brian and Albert plan to work on the ballot to propose to the task force
- Ran out of time trying to discuss:
  - collection event/status variable association, which is not reported through the GEM interface right now.
  - Possible timing issues related to E87

**Attachment:** SEMI NA-ICC-GEM300-TF Report Winter 2025

## 6 Next Meeting and Adjournment

The next meeting is scheduled for Wednesday, June 4, 2025, from 9:00-12:00, 1:00-4:00 PM Pacific Time at SEMI HQ/Milpitas. See <http://www.semi.org/standards-events> for the current list of events.

Adjournment: 2:31.



Respectfully submitted by:

Michelle Sun  
Coordinator  
SEMI North America  
Email: [msun@semi.org](mailto:msun@semi.org)

Minutes tentatively approved by:

<Name> (<Company>), Co-chair	<Date approved>
<Name> (<Company>), Co-chair	<Date approved>

**Table 14 Index of Available Attachments#1**

<i>Title</i>	<i>Title</i>
Required Meeting Elements March 2024	IC-Staff Report Feb 2025 v2
IC-Minutes-Feb-2025	AR - 7240B v2
IC Taiwan Liaison Report_20241129_V1	AR - 7312
JA_I&C_Liaison_2025_Feb_Ver2	AR - 7316
AR - 7321	ABFI TF Meeting_022425
CDS TF Meeting 20250225_v2	DDA TF Report - February 2025_Rev 1.0
GUI TF Report - 2025-02-25	PCS-TF-report20250224
SensorBusTF-SEMINA-Feb-2025-v0.1	SEMI NA-ICC-GEM300-TF Report Winter 2025

#1 Due to file size and delivery issues, attachments must be downloaded separately. A .zip file containing all attachments for these minutes is available at [www.semi.org](http://www.semi.org). For additional information or to obtain individual attachments, please contact [SEMI Staff Name] at the contact information above.